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NAVAL POSTGRADUATE SCHOOL Monterey, California





THESIS

USE OF THE GPIB FOR DATA COLLECTION AND DISPLAY

by

Thomas Taylor

June 1985

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Thesis Advisor:

John P. Powers

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REPORT DOCUMENTATION PAGE	READ INSTRUCTIONS
REPORT NUMBER	DEFORE COMPLETING FORM
H1594	25
TITLE (and Sublitic)	S. TYPE OF REPORT & PERIOD COVERED
USE OF THE GPIB FOR	Mestar's Thesis
	Tune 1985
DATA COLLECTION AND DISPLAY	6. PERFORMING ORG. REPORT NUMBER
	6. CONTRACT OR GRANT NUMBER(+)
Thomas Taylor	
PERFORMING ORGANIZATION NAME AND ADDRESS	10. PROGRAM ELEMENT, PROJECT, TASK
N . 1 Destanda Cabaal	AREA & WORK UNIT NUMBERS
Naval Postgraduate School	
monterey, California 93943-3100	
CONTROLLING OFFICE NAME AND ADDRESS	12. REPORT DATE
Naval Postgraduate School	June 1985
Monterey, California 93943-5100	13. NUMBER OF PAGES 74
MONITORING AGENCY NAME & ADDRESS(If different from Controlling Office) 15. SECURITY CLASS, (of this report)
	154. DECLASSIFICATION DOWNGRADING SCHEDULE
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Test equipments evaluated include: The Wavetek Model 270 programmable function generator, Tektronix DC5009 programmable counter/timer, Tektronix DM5010 programmable digital multimeter, Tektronix PS5010 programmable power supply, Hewlett-Packard 1615A programmable logic analyzer, and the Photodyne Model 488XLI GPIB interface and digital power meter. These equipments and others are evaluated singlely and in combination. Various methods for displaying and plotting acquired data are discussed and evaluated.

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Use of the GPIB for Data Collection and Display

by

Thomas Taylor Lieutenant, United States Navy B.S., University of Utah, 1977

Submitted in partial fulfillment of the requirements for the degree of

HASTER OF SCIENCE IN ELECTRICAL ENGINEERING

from the

NAVAI POSTGRADUATE SCHOOL June 1985

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	Lean of Science and Engineering

ABSIBACT

thesis The objective of this study is to examine the uses of a General Furpose Interface bus (GPIB) to link a microcomputer controller to computer-controllable test equipment. Ihe Revlett-Fackard HP-E5 microcomputer is examined as the system controller. The test equipment is configured to conduct tasic electronic laboratories and the results are compared with current manually-controlled test equipment. Test equipments evaluated include: The Wavetek Nodel 270 prograssable function generator, Tektronix DC5009 programmable ccunter/timer, Tektronix DM5010 programmable digital sultiseter, Tektronix P55010 programmable power supply, Hewlett-Packard 1615A programmable logic analyzer, and the Photodyne Model 488XII GPIB interface with digital LOMEL These equiptents and others are evaluated singlely meter. and in combination. Various methods for displaying and rlotting acquired data are discussed and evaluated.

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I. INTRODUCTION

Spurred by the lcw cost and availability of microcomputers and other similar products of the integrated circuit revolution, new uses of microcomputers and other programmable equipments are becoming widespread. The use of microcomputers to control data acquisition, and, once the data has been acquired, to optimally display results is much faster and often more accurate than manual methods. Basic electronics laboratories for courses such as EC-2211. EC-2212 and EC-2215 taught at the Naval Postgraduate School, and tasic digital courses such as EC-2811 and EC-2812 currently use non-programmable test equipment. The use of a microcomputer controller and programmable test equipment could provide the following advantages over the current manual methods:

- (1) More consistent results in repeated measurements, since a computer-controlled system is not subject to operator fatigue.
- (2) Greater throughput because computer-controlled systems are generally faster than manual methods.
- (3) More thorough testing because system speed allows more parameters to be measured in a shorter time.
- (4) Results expressed in scientific or engineering units, since many system controllers are capable of on-line data manipulation.
- (5) Greater accuracy because system errors can be measured automatically by comparison to theoretical or pretabulated values, stored and accounted for in the results.

(6) Adaptive data acquisition where a system can be programmed to branch to other measurements to help rinpoint problems when it measures an abnormal condition.

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- (7) Capability to store measurement results in computer memory, on disk or tape, or on a hard copy.
- (8) Better data display, since microcomputer-generated graphs and plots have obvious advantages in time and accuracy over those done by hand.
- (9) Immediate feedback to students since data plots are readily available for interpretation.

The objective of this study was to show how the use of a microcomputer and programmable test equipment could replace the current procedure for conducting basic electronic laboratories. Methods for data collection and display were examined and compared to manual methods.

Tc meet the objectives of this study various programmable test equipments were evaluated . Programs for the HP-85 computer were written to aid in the evaluation. Chapter II discusses the General Purpose Interface Bus and gives scme background on its adoption as IEEE Standard 488-1978. Chapter III is an introduction to the equipment used in this study including a summary of each equipment's capabilities. Chapter IV discusses the use of programmable test equipment for data collection. The frequency response of a simple circuit is evaluated as a demonstration. Chapter V discusses the display of data acquired from programmable test equipment including computer-generated plots examples of which are shown. Appendix A is an ASCII and IEEE 488 code chart and Appendix B is a collection of the programs developed to demonstrate and evaluate the programmable test equipment.

II. GENERAL PURPOSE INTERFACE BUS

There are many applications where the measurement power of interactive instruments can be further enhanced by coupling them to a desktop computer or minicomputer. Cperating in a remote mode can provide more exact, errcrcorrected results as compared with conventional manual operation techniques.

Presently, three major factors have combined to reduce significantly the engineering development costs of configuring measurement systems:

- Distributed computing through the growing number of instruments with internal microprocessors,
- (2) The broad choice of computers ranging from inexpensive, easy-tc-program desktop computers to more sophisticated computer systems capable of managing multi-station instrument clusters and complex data bases, and
- (3) The availability of standard interface equipment such as the GPIB which allows the easy interface of different equipments from different manufacturers.

In 1972, the U.S. Advisory Committee, composed of diverse interests representing both users and manufacturers established initial goals and then adopted an interface concept. The Hewlett-Packard Corporation had for some time teen a leader in measurement technology research, and the HP Interface Bus was adopted by the committee as an appropriate starting point. A draft document was subsequently written and evaluated by members of the committee, and then submitted as the U.S. proposal to the International Electro-technical Commission (IEC) in the autumn of 1972. Since then, the interface has undergone a number of minor changes to accommodate various needs at the international level.

In September 1974, the parent technical committee, IEC TC76, approved the main interface draft document for a formal ballot among the member nations of the IEC. Balloting took place in 1976, and IEC recommendation 625-1 was adopted. The IEC recommendation, using a different connector, is totally compatible with the current HP-IB.

Using the HP-IB as a model the IEEE Standards Foard approved IEEE Standard 488-1975 "Digital Interface for Programable Instrumentation (GPIB)", first published in 1975 and again published in 1978 with minor editorial changes as IEEE Standard 488-1978. In January 1976, the American National Standards Institute adopted the IEEE standard and published it as ANSI Standard MC 1.1.

The standardized interface concept is now well accepted. More then 2000 products that are compatible with the IEEE Standard are today available from more then 250 manufacturers over 14 countries.

The GFIB has a party line structure where all devices on the bus are connected in parallel as shown in figure 2.1. The 16 signal lines, shown in figure 2.2, within the passive interconnecting GPIB cable are grouped into three clusters according to their functions as follows:

- (1) Data Bus (8 signal lines)
- (2) Data Byte Transfer Control Bus (3 signal lines)
- (3) General Interface Management Bus (5 signal lines)



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Figure 2.1 GPIB Bus Structure. (from Ref. 7).

The Data Input-Output (DIO) Bus consists of eight signal lines that carry data in a bit parallel, byte serial format across the interface. These signal lines carry addresses, program data, measurement data, universal commands and status bytes to and from devices interconnected in a system. Identification of the type of data present on the DIO signal



Figure 2.2 GPIB Signal Structure. (from Ref. 7).

lines is indicated by the ATN (attention) signal. When the ATN signal is true (asserted), either address or universal commands are present on the data bus and all connected devices are required to monitor the DIO lines. When the ATH message is false, device dependent data (e.g., programming data) is carried between devices previously addressed to talk and listen.

Transfer of each byte on the Data Bus is accomplished via a set of three signal lines: DAV (data valid), NRFD (not ready for data), and NDAC (not data accepted). These signals operate in an interlocked handshake mode. Two signal lines, NRFD and NDAC, are each connected in a logical AND (wired OR) to all devices connected to the interface.

The DAV signal is sent by the talker and received by potential listeners whereas the NRFD and WDAC signals are sent by potential listeners and received by the talker.

The General Interface Management Lines manage the bus to effect an orderly flow of messages. The IFC (interface clear) message places the interface system in a known quiescent state. SRQ (service request) is used by a device to indicate the need for attention or service and to request an interruption of the current sequence of events. REN (remote enable) is used to select between two alternate sources of device program data. ECI (end or identify) is used to indicate the end of a multiple byte transfer sequence or, in conjunction with ATN, to execute a polling sequence.

Data byte transfer on the DIO signal lines is accomplished using an interlocked handshake sequence on three signal lines: data valid (DAV), not ready for data (NRFD) and not data accepted (NDAC). The talker uses DAV to signal the presence of a valid byte of data on DI01-DI08. Each listener indicates its acceptance of the data by asserting RFD message false and DAC message true. The talker then asserts the DAV message false and the listener, when it is able to receive a new data byte, asserts RFD true and IAC false. Thus the handshake sequence is complete. When two or more devices are "listening" each device participates in the same handshake cycle. Data is transfered asynchroncusly at the rate of the slowest listener.

A sore complete discussion of the GPIB can be found in the IHEE Standard [Ref. 7].

III. <u>BOUIPHENT</u>

In this chapter various GPIB compatible equipment will be discussed. That equipment which seem most likely candidates for basic electronic laboratory use are discussed first and in greater detail. Equipment whose use is less readily apparent and some equipment where less research was conducted are discussed last.

A. HE-85 COMPUTER AND HP-IB

A.S. MARK

STATISTY STATISTY

The Hevlett-Packard Interface Bus (HP-IE), is Hewlett-Fackard's implementation of the IEEE-488-1978 inter-As discussed in Ref. face standard (GPIB). 1, the purpose of the HF-IB is to provide mechanical, electrical, timing, and data compatibilities between all devices adhering to the Interfacing other devices to computers has been standard. greatly simplified by the HP-IP. In general the use of the HP-IE allows the operator to concentrate on what is to be communicated and give little thought to compatibility and handsbaking. The HP-IB uses standard ASCII and easily understocd control signals.

If one uses the HP-IB option accessory, the Hewlett-Fackard Model 85 microcomputer has the necessary capabilities to allow it to function as system controller. Using the HP-IB, the HP-85 can take control of programmable test equipment, direct their operation, and store test data returned from the equipment. The computer can store data on magnetic disk or tape, display the data using built-in graphics capabilities or a remote plotter, or print a hard copy of the data.

Three primary commands that the HP-85 uses to control programmable test equipment are the "OUTPUT", "ENTER" and "TRANSFER" commands. The "OUTPUT" command is used to send data ficm the computer to the test equipment. The statement must contain the destination device address and a list of items to be output (e.g. the command OUTPUT 720; X, outputs the variable X to device 720). The "ENTER" command is used to send data from a designated equipment to the computer. The statement must contain the source device address and a list of items to be entered (e.g. the command ENTER 720: X, enters data to variable X from device 720). The "TRANSFER" command is used to move data to and from a established tuffer area. This command is used to move data from one device tc another when neither device is the bus controller the command IRANSFER 706 TO Z\$ COUNT 100. will le.a. transfer 100 bytes of data from device 706 to the buffer space designated as 2\$. The command TRANSFER 2\$ TO 710 PHS, will transfer the data in buffer space 2\$ to device 710 using fast-handshake).

Statistics in the

When a device encounters a situation which requires the controller's attention or action, it signals the controller with a service request (SRQ). A service request may be generated whenever an event such as an error or change of A service request is handled status cccurs. by the controller as an interrupt and may be processed or ignored. If the controller is programmed to process the SRQ Interrupt it must first determine who sent the interrupt, and then why the SEC was generated. The controller can determine who sent the service request by performing a parallel poll. This is like a discussion leader asking those persons with problems to raise their hands. Once the controller determines which device generated the SRQ, it can determine the specific problem by performing a serial poll. This involves

querying a device as to its status. The information returned by each device is dependant upon the nature of the device and can be found in the instruction manual for that specific equipment (e.g. error code 98 indicates an execution error for the Tektronix PS 5010 but could indicate a different type of error for some other device). A complete discussion on handling service requests can be found in Ref. 1.

B. WAVETER FUNCTION GENERATOR

A STATE AND A STATE

This section discusses the Wavetek Model 270 Programmable Punction Generator and how to control it using the HF-85 Microcomputer.

As described in Ref. 2, the Wavetek Model 270, 12 MHz Frograsmable Function Generator, is a 0.01 Hz to 12 MHz nultifunction generator that can operate in continuous, trigger, gated or burst modes, at generator levels to 20 volts peak-to-peak. The generator produces sine, triangle, and square waves, with from +5 to -5 volts of DC offset. The function generator settings can be made from the front panel or, with the General Purpose Instrument bus, from a microcomputer controlling the experiment. Numbers can be input in free format, (i.e. fixed point, floating pcint, or exponential notation). Parameters may be entered in any crder. All entries are checked for errors and displayed on Current parameter settings may be checked the front panel. by pressing the corresponding button on the front panel. Ūρ to 80 ccmplete sets of programming may be stored in the generator and rapidly recalled.

The Wavetek Model 270 Programmable Function Generator can be controlled by the HF-85 Microcomputer over the Hewlett-Fackard Interface Bus (HP-IB). The handshaking and

data transfer is accomplished as discussed in Chapter 2. The Mcdel 270 is controlled by sending commands over the GPIB data lines. The function generator interprets the commands and responds as directed. When the function generator is directed by the computer to send data, it uses the same data lines that the computer used to send commands. Table I is a partial list of function codes used by the computer to control the function generator.

TABLE I

Wavetek Function Generator Programming Commands

Control and data	Model 270 <u>Key</u>	ASCII (GPIB) <u>Character</u>
Change Sign Lecimal Foint C,19 Amplitude Mode Function Cffset Exponent Frequency Execute Cutput Cn/Cff Recall Setting Reset GPIR Address	+/- 0,1,,9 AMPL MODE FUNC OFST EXP FREO EXEC ON RCL RST ADRS	- 0,1,,9 B C D F I P Y Z

The computer and function generator are connected using the KF-IE. The function generator's factory-set address can be found by pressing the "ADRS" button on the front panel. If some other address is desired it can be entered from the front panel by pressing "ADRS", entering desired address and pressing "EXEC". The address must be used in all computerto-generator communications. The function generator output is connected to provide waveforms to desired destinations (an oscilloscope is good for demonstration purposes), the computer program is loaded, and the system is ready for operation. The sample program provided in Appendix B, was written to provide a simple hands-on means of system familiarization. It does not demonstrates all the Model 270's capabilities. To use the sample program configure a system such as the one shown in Figure 3.1. A simplified flow diagram of the program is shown in Figure 3.2.

Sec. 1



Figure 3.1 Hodel 270 Demonstration.

When the program is initiated the computer display will provide instructions for entering a function into the function generator. The user should respond to the displayed questions. The "END LINE" key is used to enter the user's response into the computer. Numbers may be entered using integer (e.g., "1000"), floating point (e.g., "15.2"), or exponential (e.g., "12E6") forms. The user will be asked to enter waveform type, amplitude, frequency, and DC offset. As each entry is made, the Wavetek Function Generator display will show that entry. After a function has been



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fully selected, the function will be gated to the function generator output and displayed on the oscilloscope, and the computer will guery the function generator as to its status. The function generator's response will be printed on the computer's printer.

The sample program also contains a section on the use of the function generator's memory. It allows the user to store functions in the Model 270's memory and to recall and display previously stored functions. This demonstrates the ability of the Wavetek function generator to store and recall up to eighty waveforms.

For a more detailed description of the function generator's capabilities, the user should refer to the Instruction Manual for the Wavetek Model 270, Programmable Function Generator [Ref. 2].

C. PS 5010 PROGRAMMAELE POWER SUPPLY

EXECUTE

XXVXXXXX

The Tektronix PS 5010 Programmable Power Supply provides a floating dual supply and a ground-referenced logic supply. Each supply has independent constant voltage modes or constant current modes with automatic crossover.

The floating supply provides 0 to +32 volts DC and 0 to -32 volts DC, both with respect to a common front panel terminal. All floating supply terminals can be elevated above ground to a maximum 150 volts peak. Voltage differences from 0 to 64 volts are available across the dual supply terminals. The floating point supplies are programmable in increments of 10 millivolts from 0 to 10.0 volts and in increments of 100 millivolts from 10.1 volts to 32.0 volts. The current is programmed in 50 milliamp increments from 50 milliamps to 1.5 amps. The logic supply provides 4.5 volts DC to 5.5 volts DC at currents to 3 amps. The logic supply is programmable in increments of 10 millivolts from 4.50 volts to 5.50 volts and in current increments of 100 milliamps over a range of 100 milliamps to 3 amps.

The front panel LED display is divided into three sections. Each section indicates the programmed current or voltage for one supply. In the operating mode, the displays show the true output voltage when operated in the constant voltage mode or current when operated in the constant current mode. A more complete description of the PS 5010 specifications can be found in Ref. 3.

Table II is a condensed list of commands used by a system controller to direct the PS 5010.

A demonstration for the PS 5010 and the DM 5010 combination is included in Appendix E. This program is discussed in the following section covering the DM 5010 Programmable Digital Multimeter.

D. DH 5010 PROGRAMMABLE DIGITAL MULTIMETER

The Tektronix DF 5010 Programmable Digital Multimeter measures and displays dc voltages, resistance, true rms ac voltages, and voltages consisting of a dc level plus an ac waveform. Range selection is automatic or manually incremented. A diode test function provides a 1 milliamp current output for diode testing. Measurements are made via frontpanel connectors or a rear-interface connector.

The DN 5010 also performs calculation for averaging, scale and offset, conversion to dBm or reference dB, and comparison. Measurements and calculations are indicated on a signed 4 1/2 digit LED display. The decimal point is automatically positioned and leading zeros are blanked.

TABLE II

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STATISTICS STATISTICS

PS 5010 Commands and Descriptions

<u>Header</u> ERR	<u>Arqument</u>	<u>Description</u> Beturns error code
ILOG	<pre>>num></pre>	Sets the logic supply current limit
INEG	<pre><pre>></pre></pre>	Sets negative floating supply current limit
INIT		Resets instrument settings to power-on state
IPOS	<num></num>	Sets positive floating supply current limit
CUT	ON	Connects all supplies to the output terminals
SET?		Feturns instrument settings
VLOG	<num></num>	Sets logic supply voltage limit
VNEG	<pre>Suum></pre>	Sets negative floating supply voltage limit
VPO S	<num></num>	Sets positive floating supply voltage limit
VLOG? VNEG? VFOS?		Feturns setting for respective supply (i.e. VNEG <num>)</num>

The operation of the DM 5010 is programmable via highlevel commands (ASCII) sent over the GPIB. The DM 5010 can send information about front panel control settings, measurements, and calculations via the bus to the GPIB controller. Measurements and calculations are triggered by internal circuitry (at a normal or fast rate), front panel push button, GPIB command, or external signal via the rearinterface connector. A more detailed description of the DM 5010 specifications and operating instructions can be found in Ref. 4.

Table III is a condensed list of commands used to control the DM 5010 via the GPIB.

TABLE III

DH 5010 Commands and Descriptions

<u>Heade</u> ACDC	<u>Argument</u> Snum>	<u>Description</u> selects the ACV+DCV function. Argument selects range.
ACV	<num></num>	selects the ACV function. Argument selects range.
DCV	<num></num>	Selects the DCV function Argument selects range.
ERR?		Returns error code.
FUNCIT	?	Returns the current function and range.
INIT		Initializes to power-on settings
CHMS	<num></num>	Selects OHMS function. Argument selects range.
SEND		Returns latest measurement.
Note:	negative or omitted	argument selects auto-range

A demonstration program for the PS 5010 Programmable Power Supply and the DM 5010 Programmable Digital Multimeter is included in Appendix B. A simplified flow diagram for this program is shown in Figure 3.3. To run the program the system is configured as shown in figure 3.4. The program is loaded and run in the HP-85 computer following the instructions displayed on the screen. The program guides the user through the setup of each of the PS 5010's voltage surplies. At each step the DE 5010 will measure and display the voltage level. The computer will also read the DM 5010 and print the reading on the printer. A WAIT 1000 (1 second delay) command is used in the program just before the computer reads the meter. This delay ensures that the computer will not try to read the meter before the reading Las settled. Reference 4 shows the maximum settling time when reading AC volts (true RMS) to be 1.2 seconds. **Tatle** IV shows a sample printout.



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Figure 3.3 PS 5010 and DE 5010 Demonstration Flow Diagram.

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FS 5010 and DH 5010 Demonstration Program Printout

LCGIC VOLTAGE IS:	4.9
NEGATIVE VOLTAGE IS:	-17.5
FCSITIVE VOLTAGE IS:	24.4

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Figure 3.4 PS 5010 and DH 5010 Demonstration Setup.

This discussion and the demonstration program cover only a small percentage of the DH 5010's capabilities. For more details refer to the programming manual [Ref. 4].

E. CIBER GPIB EQUIPEENT

This section discusses equipment which was not incorporated in the research discussed in later chapters, but which right have uses in future research.

1. The Photodyne Model 488XLI GPIB Interface and Model 22XLA Fiber Crtic Nultimeter

The Photodyne Model 488XLI GPIB Interface Adaptor provides the logic and control functions necessary to interface the Model 22XLA Fiber Optic Multimeter with a GPIB The combination of the 488XLI and 22XLA can controller. operate in either the talk-only or addressable mode, as determined by the setting of an internal switch. In the talk-only mode, it can send data to a GPIB compatible listemer at one of eight switch selectable rates, frcm 2.5 readings a second to cne reading per hour. In the addressable mode, readings may be triggered or non-triggered, depending on whether its odd or even address is received from the controller. The Model 488XLI provides an output of ASCII data, sign, and terminator. A short demonstration program is provided in Appendix B. The 488XLI and 22XLI combination is very easy to use and program.

2. Hewlett-Packard 1615A Logic Analyzer

The Hewlett-Packard 1615A Logic Analyzer offers asynchronous timing diagram measurements and synchronous state measurements for use in the design and troubleshooting of digital systems. Measurement setups are simplified with a menu system which reduces the number and complexity of front ranel keys. With the format specification menu, the desired mode of operation: timing, state, or simultaneous dual-mcde, is selected. The corresponding trace specification menus then allow entry of the desired triggering and data rarameters.

The 1615A logic Analyzer was found to be not completely compatible with the HP-85 Computer. Using the HP-85 as system controller, it was possible to set all parameters into the 1615A, but data could not be transferred from the 1615A to the HP-85. The problem in data transfer

seems to be one of a not fully compatible handshake. When the HP-85 directs the 1615A to send its data, the 1615A goes to the talk mode and places the first byte of data on the bus, however the DAV (data valid) line is not set. Since the HF-85 does not receive DAV it does not accept the first byte of data and the entire system locks up with neither the HP-85 nor the 1615A responding to keyboard inputs.

Hewlett-Packard engineers who were consulted on this problem suggested that this problem might be circumwented by directing the 1615A to transfer its data to a printer cr buffer space rather then to the HP-85 directly. Further research is needed to see if this solution will work. The 1615A Logic Analyzer would be a very valuable piece of equipment for basic digital laboratories. Efforts should be made to solve the compatibility problem or to find a compatible controller.

3. Hewlett-Packard 9111A Graphics Tablet

The Hewlett-Packard 9111A Graphics Tablet is used to input coordinate points to the microcomputer. It also has sixteer menu softkeys to allow option selection away from the computer keyboard.

It was thought that the Graphics Tablet could be used to annotate computer generated plots, however this proved not to be very workable due to the small screen on the HP-85 computer. A demonstration program, included in Appendix B, provides an introduction to the 9111A and its uses.

4. The Hewlett-Packard 59401A Bus System Analyzer

The HP-59401A Bus System Analyzer is invaluable as an aid to GPIB users in hardware design and in diagnosis of hardware and software problems encountered in GPIB compatible systems. When in the listen mode the 59401A monitors Eus traffic and can accept and store up to 32 characters from the bus for later examination. It can slow down data transfer and handshaking so they may be observed. When used in the talk mode the 59401A is used to drive the Bus. The Bus can be driven one character at a time by setting the DIO switches to the appropriate code and outputting this information to the Bus.

While the 59401A Bus System Analyzer is not itself a piece of programmable test equipment, its importance in setting up and testing a GPIB system cannot be overstated. The ability to observe and control the handshake and data transfer lines on the bus greatly simplifies the design and trouble-shooting processes.

5. <u>Wavetek DC 5009 Universal Counter/Timer</u>

DC 5009 The Tektronix Universal Counter/Timer features reciprocal frequency, period, counting events on channel B during time gates applied to channel A and totalizing measurements to 135 MHz. It also has time interval and width features of 10 ns resolution for timing measure-For repetitive timing measurements, averaging and ments. circuitry provides base modulation pseudc-random time increased accuracy over a wide range of input signals. The DC 5009 provides trigger level outputs at both the front panel and rear interface for increased measurement convenience.

The DC 5009 is GPIB programmable and allows any manually selectable function or mode to be operated over the GPIB Lus, including all input conditioning controls. **Mfter** the DC 5009 is set to the remote state by a system controller, its operating modes and settings can be set and read by programming mnemonics sent to it in ASCII code over the bus. The instrument settings may also be read while in the local state. The DC 5009 connects to the bus through a TM 5000-series power GPIB-compatible connector on the module.

Measurement results are displayed in an eight-digit LED readout, with the decimal point automatically positioned. The displayed count overflow is indicated by a flashing display. The counter also uses three digits of the seven-segment LED display to indicate internal or operating error codes and two digits for external signal probe compensation results.

Table V is a condensed list of commands used with the DC 5009. A more detailed description of the Counter/Timer's specifications and operating procedures can be found in Ref. 5.

TABLE V

DC 5009 Commands and Description

<u>Commands</u> AUTO	argument	Description Sets trigger level to signal midpoint (both channels).
AVE	<rum></rum>	Sets number of measurements averaged.
СНТ	A or B	Selects channel for succeeding input settings.
EVE	(B A)	Counts Channel B during Channel A pulse width.
FREQ	())	Measures frequency of input signal on Channel A.
INIT		Resets to current front-panel settings and power-on patameters.
PER	(A)	Measures the period of Channel A signal.
RAT	(B/A)	Measures ratio of B events to A events.
SEND		Obtains and formats new measurement results.
SET?		Qu ery returns current instrument settings.
TIME	(AB)	Measures time from A event to B event.
WID	(A)	Measures pulse width of channel A signal

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IV. DATA COLLECTION

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In the previous chapter several GPIB programmable test equipments were introduced. In this chapter it will be shown how combinations of those equipments can be used to conduct basic electronics laboratory measurements. A student in a basic electronics class, such as EC-2211 at the Naval Postgraduate School, might be asked to build and evaluate the frequency response of a simple common-emitter amplifier similar to the one shown in Figure 4.1.



Figure 4.1 Common-Emitter Amplifier.

To complete an evaluation of his circuit performance he would need a signal generator, power supply, frequency counter, AC voltmeter, and an oscilloscope. He would need to become familiar enough with each of these equipments to ensure that any data obtained from his tests was correct. Problems incountered must first be investigated for equipment setup problems.

A greatly simplified procedure for investigating the same common-emitter amplifier would use programmable test equipment and a microcomputer controller. A program would insure proper equipment setup and could even perform a check to verify a proper circuit to be tested. This check would help the student identify problems in his circuit before time was lost in taking useless test data. Finally the microcomputer controlled test could take a greater number of data points at a much faster rate.

To test a common-emitter amplifier and obtain a printout of frequency and gain, the following test equipment could be used: HP-85 Microcomputer, Model 270 Function Generator, PS 5010 Fower Supply, and the DM 5010 Digital Multimeter. The equipment configuration for this type of an experiment is shown in Figure 4.2.

A sample program for the HP-85 Nicrocomputer which uses the equipment as configured in Figure 4.2 to test a commonemitter amplifier is included in Appendix B. The program uses the Wavetek Model 270 Function Generator to provide a known input to the circuit under test. The Model 270 is shifted through a range of frequencies at a constant voltage. At each frequency the test circuit's output voltage is read by the DM5010. The HP-85 Computer computes the gain at each frequency using the DN5010 readings and the known input voltage value. A simplified flow diagram for this program is shown in Figure 4.3. This program allows the user to select power supply voltages, frequency range, and number of data points to be taken. It prints out the


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Figure 4.2 Equipment Setup for C-E Amplifier Test.

frequency and gain (in dB) for each point. All user entries are made from the H2-85 keyboard in response to displayed questions. A sample of the type of output generated is shown in Table VI.

The sample program is not limited to use with simple common-emitter amplifiers; it can test the frequency-vs-yain characteristics of any desired circuit, such as an amplifier or filter. A frequency counter is not needed due to the good frequency accuracy of the Model 270 Function Generator (but could easily be incorporated in the measurement system). Many more advanced electronics courses could use the same test equipment and program for frequency-vs-gain characteristics.



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TABLE VI

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Sample Output from Frey-Gain Program

FRECUENCY-	VS-GAIN
FREÖ:	GAIN:
TÕ.OHz	-182.82dB
50009.0Hz	36.25dB
100008.0Hz	35.50dB
150007.0Hz	34.90dB
200006.0Hz	34.27dB
250005.0Hz	33.514B
300004.0Hz	32.65dB
350003.0Hz	32.65dB
400002.0Hz	30.44dB
450001.0Hz	29.18dB
SCOOOD OHZ	<u> </u>
242229.0HZ	25. 200B
233338. UHZ	24.0308
660006 0HZ	20.7008
C333390.01Z	20.7008
	11 7948
	6 1149
0/1001 047	
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V. DATA DISPLAY

In the previous chapter it was shown how computer controlled test equipment could obtain faster, more accurate test data. If this was all the computer could do it would be a major savings of time, however the computer can also provide a display of the data.

A. HP-85 GRAPHICS CAPABILITIES.

The HP-85 Microcomputer provides two different display areas or modes: alphanumeric and graphics. Normally the display is in the alpha mode, but the user can view the current graphics display at any time by pressing the "GRAPH" key or by executing the statement, GRAPH. The graphics capability of the HP-85 enable the user to:

- (1) Plot data on the graphics display, thus clarifying a complex set of information in pictorial form.
- (2) Scale the display to desired proportions.
- (3) Generate a number of lines, curves, diagrams and designs on the display.
- (4) Copy anything from the graphics display to the printer with one command.
- (5) "Draw" and latel graphs with ease.
- (6) Interact with the graphics display from the keyboard.
- (7) Execute any graphics command from the keyboard cr in a program.

If the HP-85 is equipped with the Printer/Plotter ROM, graphics programs for the HP-85 can be plotted directly on the Hewlett-Packard 7470A Plotter by using the "TRANSLATE" command.

In Chapter 4 it was shown how the frequency verses gain characteristics for a common-emitter amplifier could be measured and printed. The same data could be plotted by the HP-85 directly. This would provide the student with a quick graphical display of the amplifiers gain characteristics. Included in Appendix B is a program which will test the amplifier, print frequency and gain for each test point, graph the data, and copy the graph on the printer. Figure 5.1 is an example of the printed graph for the circuit shown in Figure 4.1 . A simplified flow diagram for the demonstration program is shown in Figure 5.2



Figure 5.1 C-E Amplifier Characteristics.



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As was previously discussed this type of program is not limited to testing one circuit. More complex circuits can also be tested using the same program. Figure 5.3 is an example of a Butterworth bandpass filter.



Figure 5.3 Butterworth Bandpass Filter.

Figure 5.4 shows the printed output for the circuit shown in Figure 5.3 using the same program that was used to test the common-emitter amplifier.

B. VISICALC PLUS

For some graphics applications, such as a logarithmic graph, a simple HP-85 program is not sufficient. For extensive or specialized graphics a pre-written graphics program package is desirable: one such program is the Hewlett-Packard VisiCalc Plus package. Briefly the HP-87 VisiCalc Plus package is a group of graphics and calculation programs for the HP-36/87 Microcomputers. The package contains the following programs:



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Figure 5.4 BP Filter Characteristics.

- VZCALC: A binary program that is the main VisiCalc program.
- VZLINE: A BASIC program that uses VisiCalc data to graph line charts.
- VZCURV: A BASIC program that allows you to fit standard regression curves to VisiCalc data.
- VZPIE: A BASIC program that uses VisiCalc data to plot pie charts.
- VZEAR: A BASIC program that uses VisiCalc data to create tar charts.
- LINCURG: A binary program that is automatically loaded and executed by the four graphics programs.
- RECZERy: A binary program that is automatically

loaded and executed by VZLINE, VZCURVE, and VZBAR.

VZREAD: A BASIC program that allows you to read data files created by VisiCalc.

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VZWRITE: A BASIC program that allows you to create VisiCalc data files from numeric arrays.

A detailed description of VisiCalc Plus can be found in Ref. 6.

The HP-87 version of VisiCalc Plus was used to generate the graphs shown in Figures 5.5 and 5.6. A HP-85 version of VisiCalc Plus is available, but was not tested in this study. In order to use VisiCalc Plus to plot the commonemitter amplifier data, the data must be put on disk as a numeric data array. An HP-85 program to take the data samples and write them on a disk correctly formatted is provided in Appendix B. Once the data is on disk it can be used by VisiCalc Plus on a HP-86 or HP-87 micrecomputer system. VZWRITE is used to create a VisiCalc data file from the data on the disk. Figures 5.5 and 5.6 show VisiCalc graphs of the common-emitter amplifier data.

Many graphics programs such as VisiCalc Plus are available for data display. The Standard Programming Package for the HP-85 Microcomputer contains some graphics programs which could be used to display acquired test data.



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Pigure 5.5 C-E Amplifier, Low Frequency.

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VI. CONCLUSIONS AND RECOMMENDATIONS

A. CCECLUSIONS

It has been demonstrated, for at least a simple experiment, that programmable test equipment could replace the presently used manually operated test equipment. The question that must be answered is, whether replacing current test equipment with programmable test equipment is a good decision in terms of cost compared to benefits received? As has been previously discussed, some of the benefits of a computer controlled system over conventional manual methods are:

- (1) More consistent results in repeated measurements, since a computer controlled system is not subject to operator fatigue.
- (2) Greater throughput because systems are generally faster.
- (3) More thorough testing because system speed allows more parameters to be measured in a shorter time.
- (4) Results expressed in engineering or scientific units, since many system controllers are capable of on-line data manipulation.
- (5) Greater accuracy because system errors can be measured automatically, stored and accounted for in the results.
- (6) Adaptive data acquisition where a system can be programmed to branch to other measurements to help pinpoint the problem when it senses an abnormal condition.

- (7) Measurement results can be stored in computer memory, on disk or tare, or on hard copy.
- (8) Computer graphics and plotting provide improved data presentation capabilities.
- (9) Students would gain some familiarity with the uses and operation of a microcomputer.

Some of the disadvantages of a computer controlled system are:

(1) Cost, since computer-controlled test equipment systems are currently much more expensive then manually operated test equipment. A quick study of Ref. 8 shows HP-IE compatible test equipment to be from two to five times as expensive as similar test equipment without the HP-IE option.

Hewlett-Packard has recently (May, 1985) introduced a new line of programmable test equipment called the PC Instruments system. This equipment is not GPIB compatible without optional hardware, but it does provide computer-controllable test equipment using a different bus structure. The cost of this equipment is roughly twice that of manual test equipment. Hewlett-Packard has software available for several of thier computer types for use with this equipment.

- (2) Students would not be required to be as familiar with the test equipment if it is computer-controlled.
- (3) Students could complete a experiment in a cookbook fashion and not really understand what they are dcing.

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B. RECOMMENDATIONS

Based on this study the following recommendations are made:

- (1) As replacement test equipment is needed, the replacements should be GPIB compatible. The large cost difference between GPIB compatible and manually operated test equipment should become less as GPIE equipment becomes more common. The advantages of computer controlled systems discussed in the previous section are greater then the disadvantages.
- (2) Software develogment should begin immediately covering all the basic electronics laboratories. If the software development is done now it would be available and tested before the equipment is Even if the decision is made not to purchased. purchase GPIB compatible equipment, the software development would be worthwhile material for future thesis students.
- (3) Other GPIB compatible test equipment should be purchased and tested. This would ensure that future purchases of large numbers would be based on in-house research and not on slick salesmanship. Also other equipments could lead to uses not currently anticipated.

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84	811 83	7 S B2	81	CON	TROL		NUM	UMBERS			UPPER CASE			LOWER		
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Ľ		Ľ	Ľ	0 (0)	10 (16)	20	(32)	30	1481	40	(64)	50	(00)	••	1961	70 (112)
0	0	Ø	1	SOH	DC1	•••	!		1	A		" Q		141	8	q
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Ľ	Ľ		Ľ	7 (7)	17 (23)	27	(39)	37	1 (55)	47 47	(71)	57	(87)	67	¥ (103)	77 (119)
1	0	0	0	BS	CAN	50	(70	8	110 H		130 X		150	h	170 X
			\vdash	8 (8) 11 1CT	18 (74) 31 SPD	28 51	(40)	38 71	(56)	48	(72)	50 131	(98)	68 151	(104)	7 <u>6 (120)</u> 171
1	0	0	1	HT 9 (9)	EM 19 (25)	20) (41)	30	9 (\$7)	49	(73)	50 Y	(89)	69	i (105)	y 79 (121)
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-			_	A (10)	1A (26)	2A	(42)	3A 71	(58)	44	(74)	5A -	(90)	64	(106)	7A (122)
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APPENDIX A ASCII & IEEE 488 (GPIB) CODE CHART

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APPENDIX B

GPIB PROGRAMS

A. WAVETER MODEL 270 DEMONSTRATION PROGRAM

The following program provides an introduction to the Wavetek Model 270 Function Generator using the HP-85 computer as controller.

"Wavetek Function Generator"

10 I program to control
20 ! Wavetek Model 270
30 ! Function Generator
40 CRI IS 1
50 ! Slave Wavetek tc HP-85
60 REMOTE 720 !assumes wavetek address is 20
70 I Lockout Wavetek front
80 ! Panel control
90 ICCAL LOCKOUT 7
100 ! Select function
110 CLEAR
120 DISP "ENTER FUNCTION NUMBER"
130 DISF
140 CISP "SINE WAVE = 0"
150 DISF "TRIANGLE WAVE = 1"
160 DISP "SQUARE WAVE = 2"
170 DISP
180 INPUT C
190 CTIPUT 720; "C",C
200 ! select amplitude
210 CLEAR
220 DISP "ENTER AMPLITUDE IN VOLTS"
230 DISE WINAT 10 V. PEAKYW

240	DISF
250	INPUT A
260	CETFUT 720;"A", A
270	I select frequency
280	CLEAR
290	EISP "ENTER FREQUENCY IN HZ"
300	DISP "(MAX 12MHz)"
310	LISP
320	INPUT F
330	OUTFUI 720; "F", F
340	! select DC offset
350	CLEAR
360	DISF "ENTER DC CFFSET"
370	DISP "(+ OR - 5 V. MAX)"
380	DISF
390	INPUT D
400	CUTFUI 720;"D",L
410	! select DC offset
420	CLEAR
430	DISP "ENTER O TO EXECUTE"
440	DISP "YOUR FUNCTION"
450	DISP "ENTER OTHER THEN O"
460	DISF "TO CHANGE FARAMETERS"
470	LISP
480	INFUT B
490	IF E <> 0 THEN 110
500	CUTFUT 720; "B",E
510	CUTPUT 720; "P11"
520	! input status of Wavetek
530	OJTPUT 720; "XT31"
540	ENTER 720; F,A,D,B,C,P,G
545	!print Wavetek parameters
550	PRINT "WAVETEK PARAMETERS"
560	FRINI
570	IF C=0 THEN LET C\$="SINE WAVE"

580 IF C=1 THEN LET CS="TRIANGLE WAVE" 590 IF C=2 THEN LET C\$="SQUARE WAVE" 600 PRINT "FUNCTION",C\$ 610 PRINT "FREQUENCY (Hz) ", F 620 FRINT "AMPLITUDE (VOLTS)", A 630 PRINT "DC OFFSET (VOLTS) ", D 640 FRINT 650 CLEAR 660 ! ask for next function 670 DISP "DO YOUT WISH TO ENTER" 680 DISF "ANOTHER FUNCTION (Y/N) ?" 690 INPUT YS 700 IF YS="Y" THEN 110 710 CLEAR 715 I store function in memory 720 DISE "DO YOU WISE TO STORE" 730 DISP "YOUR FUNCTION IN MEMORY" 740 DISF "(I/N) ?" 750 INPUT NS IF NS="N" THEN 860 760 770 CLEAR 780 DISF "ENTER MEMCRY ADDRESS" 790 EISP "(1 TO 80)" 800 INFUT M 810 CUTPUT 720; "F",F,"C",C,"A",A,"D",D,"BOP1","M",M 820 CLEAR 830 **LISP "YOUR FUNCTION IS"** 840 DISE "STORED IN MEMORY" 850 DISP "LOCATION: ",M 860 DISF 865 ! recall a function from memory 870 DISF "DO YOU WISH TO" 880 DISP "RECALL AND EXECUTE" 890 DISF "A PROGRAM STORED IN" 900 CISP "WAVETEK MEMORY (Y/N) ?"

910 INPUT NS 920 IF N\$="N" THEN 1130 930 CLEAR 940 DISP "ENTER MEMCRY LOCATION" 950 CISP "OF STORED FUNCTION" 960 INPUT Y 970 CUTPUT 720; "Y", Y,"I" 980 CLEAR 990 DISP "FUNCTION FROM MEMORY" 1000 DISP "LOCATION: ",Y 1010 DISP "IS NOW BEING EXECUTED" 1020 DISP 1030 DISP "DO YOU WISH TO RECALL" 1040 DISP "ANOTHER FUNCTION (Y/N) ?" 1050 DISP 1060 INFUT Y\$ 1070 IF Y\$="Y" THEN 940 1080 CLEAR 1130 DISP "DO YOU WISH TO ENTER" 1140 DISP "ANOTHER FUNCTION (Y/N) ?" 1150 INPUT Y\$ 1160 IF Y\$="Y" THEN 110 1170 DISP "GOODBYE" 1180 SIOP 1190 END

PS 5010 AND DH 5010 DEMONSTRATION PROGRAM B.

k

This program demonstrates some of the capabilities of the Tektronix PS 5010 Programmable Power Supply and the DM 5010 Programmable Digital Multimeter. The HP-85 computer is assumed as controller. If some other controller is used, the ccde may need modification.

! Program to demcnstrate
the PS 5010 and DM 5010
1 Addresses must be
I DM = 16
1 ps = 22
$\frac{1}{1} = \frac{2}{2}$
1 before sending any inst
l after nover ur
S-SPOLL (710)
set PS to power-on state
CUTFUI 722;"INII"
FRINT
CLEAR
! logic supply demo
DISF "CONNECT DM TO LOGIC SUPPLY"
DISP
DISF "ENTER LOGIC SUPPLY VOLTAGE"
DISP "(+4.5 TO +5.5 VOLTS)"
INFOT L
IF L>=4.5 AND L<=5.5 THEN 230
DISF "YOU HAVE MADE AN ERROR"
DISP "TRY AGAIN"
GOTC 150
! set DM to read dc volts
CUTPUT 716;"DCV"
I SET PS LOGIC SUPPLY

245 ! turn PS output on 250 OUTPUT 722: "OUT ON" 252 ! delay to give meter time 253 ! tc read voltage 255 WAIT 1000 260 ! enter meter reading 270 CUTPUT 716:"SEND" 280 ENTER 716:A\$ FRINT "LOGIC VOITAGE IS:"A\$ 290 300 PRINT 310 CISF 320 EISP "THE DM READING SHOULD AGREE" 330 **DISP "WITH THE FRINTOUT AND THE"** 340 DISP "LOGIC SUPPLY DISPLAY" 350 CISP 360 DISP "DO YOU WISH TO TRY AGAIN (Y/N) ?" 370 INPUT YS 380 IF Y\$="Y" THEN 150 385 ! set PS to power-on state 390 CUTFUT 722; "INIT" 400 CLEAR 405 ! negative supply demo 410 CISP "CONNECT DN TO NEGATIVE" 420 CISE "FLOATING SUPPLY" 430 CISP 440 DISF "ENTER NEGATIVE VOLTAGE" 450 CISP "(0 TO -32 VOLTS)" 460 INFUT N 465 ! check for input within tolerance 470 IF ABS(N) >= 0 AND ABS(N) <= 32 THEN 510 480 CISP "YOU HAVE MADE AN ERROR" 490 DISP "TRY AGAIN" 500 GOTC 430 505 ! set negative supply voltage 510 CUTFUT 722; "VNEG", N

ALLER CONTRACT PARAMETER

! turn on PS output 515 520 OUTPUT 722; "OUT ON" 525 ! delay for meter 530 WAIT 1000 ! read DM 535 540 CUTPUT 716; "SEN L" 550 ENTER 716;N\$ 560 PRINT "NEGATIVE VOLTAGE IS:", N\$ 570 FRINT 580 CISP "TRY ANOTHER VALUE (Y/N)?" INPUT YS 590 600 IF YS="Y" THEN 400 605 ! set PS to power-on state 610 OLTPUT 722; "INII" 620 CLEAR ! positive supply 630 640 DISP "CONNECT DN TO POSITIVE" 650 DISP "FLOATING SUPPLY" DISP 660 CISP "ENTER DESIRED VOLTAGE" 670 DISF "(O TO 32 VCLTS)" 680 690 DISP INFUT P 700 705 ! check for input within tolerance 710 IF P>=0 AND P<=32 THEN 750 DISP "YOU HAVE MADE AN ERBOR" 720 730 DISP "TRY AGAIN" 740 GOTC 660 745 ! set positive supply voltage 750 OUTPUT 722;"VPOS", P 760 OUTPUI 722; "OUT ON" 765 ! delay for meter 770 WAIT 1000 775 l read DM 780 OUTPUT 716; "SEN C"

790	ENTER 716;P\$
800	FRINI
810	PRINT "POSITIVE WOLTAGE IS:",P\$
820	DISP "DO YOU WISH TO CHANGE VPOS"
830	EISP "(Y/N) ?"
840	INPUI Y\$
850	IF Y\$="Y" THEN 660
860	CCTPUT 722;"INIT"
870	CLEAR
880	DISF "GOODBYE"

890 END

C. 488XLI AND 22XLA DEMONSTRATION PROGRAM

This program provides a simple demonstration of some of the capabilities of the Photodyne 488XLI and 22XLA combination. An input may be provided to the 22XLA but is not necessary for this demonstration.

10	! 488XLI and 22XLA Demonstration
20	! Ncn-trigger address is 02
30	! Termination sequence is CR-LP
35	! Set termination sequence
40	CCNIROL 7,16,; 130,13,10
50	CLEAR
60	DISP "488XLI SAMFLE PROGRAM"
70	! read data from 22XLA via 488XLI
80	ENTER 702;A
90	LET A=A/100
100	! Display data on CRT
110	DISP USING 120;A
120	IMAGE DDDD.DD,"IEM"
130	GOIO 70

140 END

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D. PROGRAM TO DEMONSTRATE THE HP-9111A GRAPHICS TABLET.

This program demonstrates some of the uses of the Hewlett-Fackard Hodel 9111A Graphics Tablet when used with the HP-85 Microcomputer. The HP-85 and HP-9111A are the only equipment needed for this program. This program is a modification of a program found in Ref. 9.

10	! program for 9111A Graphics
20	1 Tablet
30	! Tablet address = 06
35	! Print softkey menu
40	FRINT "SOFTKEY 1 = COPY CET TO PRINTER"
50	PRINT "SOFTKEY 2 = ERASE CRT AND CLEAR FILES"
60	FRINT "SOFTKEY 3 = SINGLE-SAMPLE MODE"
70	PRINT "SOFTKEY 4 = SWITCH-FOLLOW,"
80	FRINT "CONTINUOUS-SAMPLE NODE"
90	PRINT "SOFTKEY 5 = SWITCH-NORMAL,"
100	FRINT "CONTINUOUS-SAMPLE MODE"
105	! set variables and IC's
110	CPTICN BASE 0
120	CIM K\$ {25}
130	K\$="BF36,50,3;BF34;BP32;BP30"
140	SHORT X (1000), Y (1000),
150	INTEGER P(1000)
160	X (0), Y (0), P (0), J, F 1=0
170	FLOTTER IS 1
175	! initialize tallet
180	OCIPUT 706; "IN: CN: SF"
185	! initialize graph
190	GCLEAR
200	GRAPH
210	LIMIT 0,97,0,70
220	FRAME
230	SCALE 0,301,0,218
240	FCR I=1 TO 5

```
250 BEAD V
260 1$ {1,1}=CHR$ (V)
270 NEXI I
280 DATA 4,4,31,4,4
285 ! check for interrupt
290 CN INTR 7 GOSUB 390
300 OCTPUT 706; "IN, 132"
310 ENABLE INTR 7,8
315 ! input tablet coordinates
320 CUTFUT 706; "OC" & ENTER 706; x, y
330 X=X/40 3 Y=Y/40
340 IF X<5 OR X>300 THEN 320
350 IF Y<1 OR Y>216 THEN 320
360 MOVE X-5, Y+2 @ BPLOT T$,1 @ MOVE
     1-5,1+2 @ BPLOT 1$,1
370 GOTO 320
380 ! Check status of interrupt
390 STATUS 7, 1; A
400 CUTPUI 706: "OS"
410 ENTER 706:51
420 IF BIT(S1,2) THEN GOSUB 450
430 IF BIT (S1,7) THEN GOSUB 530
440 ENABLE INTR 7,8 @ RETURN
450 IF F1=1 THEN PLCT X(J), Y(J), P(J)
460 J=J+1
470 IF J>1000 THEN 590
480 OCTPUT 706; "OD"
490 ENTER 706;S,T,U
500 X (J) = S/40 @ Y (J) = T/40 @ P (J) = U
510 FLOT I(J), Y(J), P(J)
520
    BETURN
530 OUTPUT 706; "R S1"
540 ENTER 706;K
550 CUIPUT 706;K$
560 ! Call subroutine dependant on menu softkey
```

```
59
```

CH K GOSUB 670,700,750,800,850,730,730,730, 570 730,730,730,730,730,730,730,730 580 RETUEN 590 GCLEAR 600 FRAME 610 MOVE X(1), Y(1) 620 FOR J=1 TO 1000 630 FLOT X(J), Y(J), P(J) 640 NEXT J 650 END 660 ! Subroutine to copy graph 670 COPY 680 RETURN 690 ! Subroutine to clear graph 700 GCLEAR 710 FRAME 720 J=0 730 RETURN 740 ! Subroutine for single-sample mode 750 CUTPUT 706; "SG" 760 F1=1 770 P(J)=0 780 FETURN 790 ! Subroutine for switch-follow, continuous-sample mode 800 OCTPUT 706; "CN: SF" 810 F1=0 820 F(J) = 0830 RETURN 840 I Subroutine tor switch-normal continuous-sample mode 850 OTTPUT 706;"CN; SN" 860 F1=0 870 P(J)=0 880 FEIURN

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E. FREQUENCY-VS-GAIN PROGRAM (PRINTED OUTPUT)

This program will test and print out the frequency and gain at that frequency for a circuit connected to the programmable test equipment:

10	! Program for freg-gain
20	! Test equipment addresses
30	! Function generator = 20
40	I Power supply = 22
50	! Multimeter = 16
60	! Poll test equipment
70	LOCAL LOCKOUT 7
80	S=SFOLL (722)
90	S=SPOLL (716)
100	! Initialize test equipment
110	OLTPUT 716; "ACV"
120	CUTFUT 722;"INIT"
130	Set power supply
140	CLEAR
150	DISP "ENTER NEGATIVE VOLTAGE"
160	DISF "(O TO -32 VOLTS)"
170	INPUT N
175	! check input within tolerance
180	IF ABS (N) <= 32 THEN 220
190	DISP "YOU HAVE MADE AN"
200	DISF "INCORBECT ENTRY"
210	GO TO. 150
220	CUTFUT 722; "VNEG", N
230	DISP "ENTER POSITIVE VOLTAGE"
235	DISP "(O TO 32 VCLTS)"
240	INPUT P
245	! input within tclerance?
250	IF P>=0 AND P<=32 THEN 290
260	DISP "YOU HAVE MADE AN"
270	DISF "INCORRECT ENTRY"

280	GOIO 230
29 0	CUIFUT 722; "VPOS", P
300	I Enter other parameters
310	DISP "ENTER STARTING FREQUENCY"
320	INPUT F1
330	DISF "ENTER ENDING FREQUENCY"
340	INPUT F2
345	l check frequencies
350	IF F1 <f2 400<="" th="" then=""></f2>
360	DISF "ENDING FREQUENCY IS"
370	DISF "LESS THEN STARTING"
380	DISP "FREQUENCY"
390	GOIC 310
400	DISP "ENTER NUMBER OF POINTS"
410	DISP "(100 FOINIS IS USUALLY ENOUGH)"
420	INPUT N1
430	! Display parameters
440	CLEAR
450	DISF "NEGATIVE VCLTAGE =",N
460	CISP "POSITIVE VOLTAGE =",P
470	DISF "STARTING FREQ =", $F1$
480	DISP "ENDING FREQ =",F2
490	DISF "# OF POINTS =",N1
500	DISP
510	DISP "DO YOU WISE TO CHANGE"
520	DISP "(Y/N)?"
530	INPUT YS
540	IF Y\$="Y" THEN 140
550	! Turn on power supply
560	CUTPUT 722; "OUT CN"
570	I Set up function generator
580	CUTPUT 720; "COA 1EOF", F 1, " P 1I"
590	! Start taking data
600	FRINT
610	PRINT "PREQUENCY-VS-GAIN"

```
620
    PRINT "PREQ: GAIN:"
630
   F2=F1
640 B = (P2 - P1) / (N1 - 1)
650 FOR I=1 TO N1
   WAIT 1000
660
665 ! read meter
670 CUTFUI 716;"SENI"
680 ENTER 716:P1
685 ! compute gain
690 G=20*LOG(P1*P1 /.5)
695 ! print frequency and gain
700 FRINT USING 710;F2,G
710 IMAGE DDDDDDD.D,"Hz",DDDD.DD,"dB"
720 F2=INT (B) *I+F1
725 1 set 270 to next frequency
730 CUTPUT 720;"F", P2,"I"
740
    NEXI I
750
    DISP "DO YOU WISH ANOTHER RUN"
760 DISP "(Y/N)?"
770
    INPUT YS
780
    IF Y$="Y" THEN 100
790
    DISF "GOODEYE"
800
    END
```

F. FREQUENCY-VS-GAIN PROGRAM (GRAPH OUTPUT)

This program is a modification of the frequency-vs-gain program of Section E using the HP-85 graphics capabilities. The data points are graphed on the computer display and then the display is copied on the printer.

10 ! Program for freq-gain (graphic) 20 ! Test equipment addresses 30 ! Function Generator = 20 40 ! Power Supply = 22 50 ! Multimeter = 16 60 ! Pcll test equipment 70 ICCAL LOCKOUT 7 75 ! initialize variables 80 DIM P1(2,150) 90 S=SPOLL (722) 100 S=SPOLL (716) 110 ! Initialize test equipment 120 OUTPUT 716; "ACV" 130 CUTFUT 722;"INIT" 140 I Set Power Supply 150 CLEAR 160 DISP "ENTER NEGATIVE VOLTAGE" 170 DISF " (0 TO -32 VOLTS) " 180 INPUT N 185 ! input within tclerance? 190 IF ABS (N) <= 32 THEN 230 200 DISP "YOU HAVE MADE AN" DISF "INCORRECT ENTRY" 210 220 GOTO 160 230 CUTPUT 722;"VNEG",N 240 DISP "ENTER POSITIVE VOLTAGE" 250 INPUT P 255 I Check if input within tolerance 260 IF F>=0 AND P<=32 THEN 300

DISP "YOU HAVE HADE AN" 270 DISP "INCORRECT ENTRY" 280 290 GOIC 240 300 OUTPUT 722: "VPOS",P 310 ! Enter other parameters 320 DISP "ENTER STARIING FREQUENCY" 330 INPUT F1 340 DISP "ENTER ENDING FREQUENCY" 350 INPUT F2 355 ! check frequency order 360 IF F1<P2 THEN 410 370 DISP "ENDING FRECUENCY IS" 380 DISP "LESS THEN STARTING" 390 DISE "FREQUENCY" GOTO 320 400 DISF "ENTER NUMPER OF POINTS" 410 420 CISP "(150 POINTS MAX)" DISF "(100 POINTS IS USUALLY PLENTY)" 430 440 INPUT N1 450 ! Display parameters 460 CLEAR 470 LISE "NEGATIVE VCLTAGE =",N 480 DISP "POSITIVE VOLTAGE =",P 490 DISE "STARTING FREQ =", F1 500 DISP "ENDING FREQ =",F2 510 DISF "# OF POINTS ="N1 520 CISP 530 DISF "DO YOU WISH TO CHANGE" 540 CISP "(Y/N)?" 550 INPUT YS 560 IF Y\$="Y" THEN 150 570 ! Turn on power supply 580 CUTFUT 722; "OUT CN" 590 ! Set up functicr generator 600 OUTPUI 720; "COA 1EOF", F1, "P11"

```
! Start taking data
610
620
    PRINT
630 PRINT "FREQUENCY-vs-GAIN"
640 PRINT "FREQ:
                         GAIN:"
650 F1(1,1)=F1
660 B = (F2 - F1)
670 FOR I=1 TO N1
675
    ! delay for meter
680
    WAIT 1000
690
    OUTPUT 716: "SENE"
700 ENTER 716:G
705 ! ccmpute gain
710 F1(2,I) = 20 \times LOG(G \times G/.5)
715
    ! print frequency and gain
     PRINT USING 730:P1(1,I),P1(2,I)
720
730
    INAGE DDDDDDD.D,"Hz",DDDD.DD,"dB"
740 P1(1,I+1)=INT(B/(N1-1))*I+F1
745
    ! set 270 to next frequency
750 CUTFUT 720: "F", P1(1, I+1), "I"
760
    NEXI I
770
    ! initialize plot
780
    GCLEAR
790
    SCALE F1-2*B, F2,-20, 110
800 XAXIS 0,.1*B
810
    YAXIS 0,10
815
    ! plot points stored
817
    ! in array p1
820
    FOR I=1 TO N1
830
    FLOI P1(1, I), P1(2, I)
840
    NEXI I
850
     FENUP
855
    ! label plot
860
    LDIR O
870 LOVE .3+B,80
880
     IABEL "MAG (dB) VS FREQ"
```

```
890 MOVE . 1*B, - 10
900 IABEL "FREQ(",. 1*B, "Hz STEPS"
910 IDIE 90
920 MOVE F1-. 1*B, 20
930 IABEL "MAG(10dB STEPS) "
935 ! ccpy plot on frinter
940 COFY
950 CISP "DO YOU WISH ANOTHER RUN"
960 DISF "(Y/N)?"
970 INPUT Y$
980 IF Y$="Y" THEN 110
990 DISP "GOODBYE"
1000 FND
```

G. FREQUENCY-VS-GAIN PROGRAM (DISK OUTPUT)

This program is a modification of an earlier frequencyvs-gain program. This program writes a file onto a disk which is compatible with the VZWRITE subprogram of VisiCalc Plus. Cutput is stored by rows, frequency and then gain. The data disk is assumed to be "INITIALIZED" and the microcomputer must be using that disk as its mass storage device.

```
10
     ! Program for Freg-Gain (disk)
 20
    ! Test equipment addresses
30
    ! Function Generator = 20
40 ! Power Supply = 22
50
    ! Nultimeter = 16
    ! Pcll test equipment
60
70
    LOCAL LOCKOUT 7
80
    S=SFOLL (722)
90 S=SPOLL (716)
100
    ! Initialize test equipment
110 OUTPUT 716; "ACV"
120
    CUTPUI 722;"INII"
130
     ! Set Power Supply
140
     CLEAR
150
    CISP "ENTER NEGATIVE VOLTAGE"
160
     DISP "(0 TO -32 VOLTS)"
170
    INPUT N
    ! input within tclerance?
175
180
     IF ABS(N) \leq 32 THEN 220
190
    DISP "YOU HAVE MADE AN"
200
    DISP "INCORRECT ENTRY"
210
    GOTO 150
215 ! set negative supply
220 OUTPUT 722; "VNEG", N
230
     DISP "ENTER POSITIVE VOLTAGE"
235
    LISP "() TO 32 VOLTS)"
240
     INFUT P
```

```
245 I input within tclerance?
250 IF F>=0 AND P<= 32 THEN 290
    DISP "YOU HAVE MADE AN"
260
270 DISP "INCORRECT ENTRY"
280 GOTC 230
285 ! set positive supply
290 OUTFUT 722:"VPOS",P
300 ! Enter other parameters
310 DISP "ENTER STAFTING FREQUENCY"
320
    INPUT F1
330 DISP "ENTER ENDING PREQUENCY"
340 INPUT F2
345 I frequencies in order?
350 IF F1<F2 THEN 400
360 DISF "ENDING FRECUENCY IS"
370 DISF "LESS THEN STARTING"
380 DISP "FREQUENCY"
390 GOTC 310
400 DISP "ENTER NUMBER OF POINTS"
405 DISF "(MAX 150)
410 DISP "(100 POINTS IS USUALLY PLENTY)
420
    INPUT N1
430
    ! Input disk filename
440 DISP "ENTER FILENAME FOR DISK"
450
    INPUT AS
460
    ! Display parameters
470 CLEAR
480 DISP "NEGATIVE VCLTAGE =", N
490 DISP "POSITIVE VOLTAGE =",P
500 DISF "STARTING FREQ =", F1
510 DISP "ENDING FREQ =" F2
520 DISE "# OF POINTS =",N1
530 DISP "FILENAME =", A3
540 DISP
550 LISP "DO YOU WISH TO CHANGE"
```

Ē

SANDARY ENGLISH CALL
```
560 DISP "(Y/N)?"
570
    INPUT YS
580 IF YS="Y" THEN 140
    ! Iurn on power supply
590
600 OUTPUI 722;"OUT CN"
610 ! Set up function generator
620 CUTPUT 720; "COA 1BOF", F1, "P1I"
630
    ! Set up disk
640 CREATE A$,300,10
650 ASSIGN# 1 TO AS
660 ! Start taking data
670 PRINT
680 FRINI "FREQUENCY-vs-GAIN"
690 PRINT "FREO
                         GA IN"
700 F2 = F1
710 P = (F2 - F1) / (N1 - 1)
720 FCR I=1 TO N1
725 ! delay for meter
730 WAIT 1000
735 ! read meter
740 CUIFUT 716: "SENI"
750 ENTER 716;P1
755 I compute gain
760 G=20*LOG (P1*P1/.5)
770 FRINI USING 810;P2,G
780 ! Write to disk
790 PRINT# 1,2*I-1;P2
800 FRINT# 1,2*I;G
810 INAGE DDDDDDD.D,"Hz",DDDD.DD, "dB"
820 F2=INT (B) *I+P1
825
    I set 270 to next frequency
830
    OUTPUT 720;"F", P2,"I"
840
    NEXI I
850
    ! Close disk file
860
    ASSIGN# 1 TO *
```

870 DISF "DO YOU WISH ANOTHER RUN" 880 DISP "(Y/N)?" 890 INPUT Y\$ 900 IF Y\$="Y" THEN 100 910 DISF "GOODBYE" 920 FND

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LIST OF REFERENCES

WAR WAR WE WARDEN

1.	Hevlett-Packar <u>quide</u> , Palo Al	d Inc. tc, Cl,	<u>Series</u> 1980.	<u>80, I</u>		<u>amning</u>
•	Nonobok Too	F1			M 1	M - 3 - 1

- 2. Wavetek Inc. <u>Freliminary Instruction Manual</u>, <u>Model</u> 270 12 <u>MHz</u> programmable Function Generator, San Diego, CA, 1982.
- 3. Tektronix Inc. Instruction Manual, PS 5010 Programable Power Supply, Beaverton, OR, 1987.
- 4. Tektronix Inc. <u>Instruction Manual</u>, <u>DM 5010</u> <u>Programmable Digital Multimeter</u>, Beaverton, OR, 1981.
- 5. Tektronix Inc. <u>Instruction Manual</u>, <u>DC 5009 Universal</u> <u>Counter/Timer</u>, Beaverton, OR, 1981.
- 6. Hewlett-Packard Inc. <u>Hewlett-Packard</u>, <u>VisiCalc Flus</u>, Palo Alto, CA, 1982.
- 7. Institute of Electrical and Electronic Engineers, Inc. <u>Standard Digital Interface for Programmable</u> <u>Instrumentation</u>, New York, NY, 1983.
- 8. Hewlett-Packard Inc. <u>Hewlett-Packard 1985</u> <u>Catalog</u>, Palo Alto, CA, 1985.
- 9. Hewlett-Packard Inc. <u>Cperating and Service Manual</u>, <u>1615A Logic Analyzer</u>, Palo Alto, CA, 1980.

BIBLIOGRAPHY

and the second second

Hewlett-Fackard Inc. <u>Operating and Service Manual</u>, <u>59401A</u> <u>Bus System Analyzer</u>, Palo Alto, CA, 1975. Photodyne Inc. <u>Instruction Manual</u>, <u>Model 488XLI GPIB</u> <u>Interface</u>, Newbury Park, CA, 1984.

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